Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination			
10765772	CHERIAN, GABE			
Examiner	Art Unit			
HOA C NGUYEN	2841			

SEARCHED						
Class	Subclass	Date	Examiner			
174	260,138G,259,263,361,255,256	5/10/06	HN			
361	743,767	5/10/06	HN			
Update search		5/11/07	HN			
Update search		1/3/08	HN			
Update search		6/3/08	HN			

SEARCH NOTES					
Search Notes	Date	Examiner			
East text search	5/10/06	HN			
Update search in 361/761,764,731,733,760,785-786	5/11/07	HN			
Update search	1/3/08	HN			
Update search	6/3/08	HN			
Consulted with Primary Examiner Randy W. Gibson with the regard to the Applicant's arguments. After reviewing the case and the arguments, Randy suggested the case should be allowed.	6/3/08	HN			

INTERFERENCE SEARCH						
Class	Subclass	Date	Examiner			
All	((substrate layer plane) and (array) and (attachment) and (pad land contact electrode) and (elongat\$3) and (direction) and (perpendicular) and (individual adj (ray line)) and (point)).clm.	6/4/08	HN			

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